

Description

The SI4151DY-T1-GE3 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -30V I_{D} = -15A$

 $R_{DS(ON)} < 8.7 \text{m}\Omega$ @ $V_{GS} = 10V$

Application

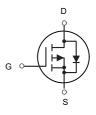
Battery protection

Load switch

Uninterruptible power supply

S_S_G

SOP-8 (SO-8)



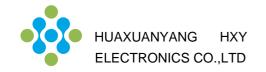
P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SI4151DY-T1-GE3	SOP-8(SO-8)	HXY MOSFET	3000

Absolute Maximum Ratings (T_c=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units	
V _D S	Drain-Source Voltage	-30	V	
Vgs	Gate-Source Voltage	±20	V	
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-15	А	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-11	А	
Ірм	Pulsed Drain Current ²	-56		
EAS	Single Pulse Avalanche Energy³	151	mJ	
las	Avalanche Current	-55	А	
P _D @T _A =25°C	Total Power Dissipation ⁴	1.5	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
Reja	Thermal Resistance Junction-Ambient ¹(t≦10s)	40	°C/W	
	Thermal Resistance Junction-Ambient ¹	75	°C/W	
R _θ JC	Thermal Resistance Junction-Case ¹	24 °C/W		



Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
∆BVpss/∆Tj	BV _{DSS} Temperature Coefficient	Reference to 25°C, I _D =-1mA		-0.018		V/°C
		V _{GS} =-10V , I _D =-12A		5.8	8.7	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-10A		8.5	13.5	mΩ
$V_{GS(th)}$	Gate Threshold Voltage		-1.2		-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		5.04		mV/°C
1	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C	°C1		-1	
IDSS		V _{DS} =-24V , V _{GS} =0V , T _J =55°C			-5	uA
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-12A		25		S
Qg	Total Gate Charge (-4.5V)			30		nC
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-12A		10		
Q_{gd}	Gate-Drain Charge			10.4		
T _{d(on)}	Turn-On Delay Time			9.4		
Tr	Rise Time	V _{DD} =-15V,V _{GS} =-10V,		10.2		ns
T _{d(off)}	Turn-Off Delay Time	$R_G=3.3\Omega$,		117		
T _f	Fall Time	I _D =-1A		24		
Ciss	Input Capacitance			3448		
Coss	Output Capacitance	 V _{DS} =-15V , V _{GS} =0V , f=1MHz		508		pF
Crss	Reverse Transfer Capacitance	VDS10V , VGS-0V , 1-11VII 12		421		Pι
Is	Continuous Source Current ^{1,5}				-14	Α
Ism	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			-56	Α
Vsp	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V
t _{rr}	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,		19.4		nS
Qrr	Reverse Recovery Charge	T _J =25°C		9.1		nC
U rr	Reverse Recovery Charge	1.5 2.5 5		9.1		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-55A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

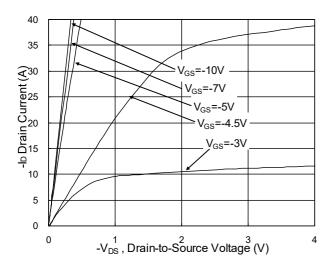


Fig.1 Typical Output Characteristics

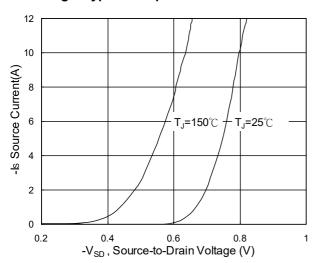


Fig.3 Forward Characteristics Of Reverse

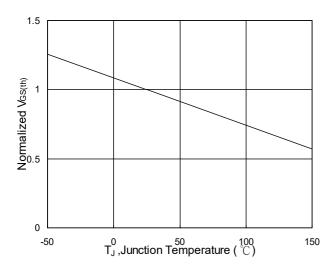


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

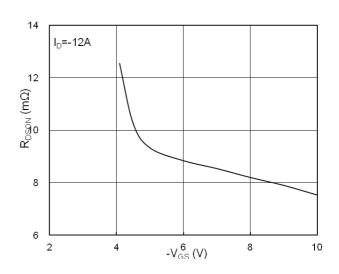


Fig.2 On-Resistance v.s Gate-Source

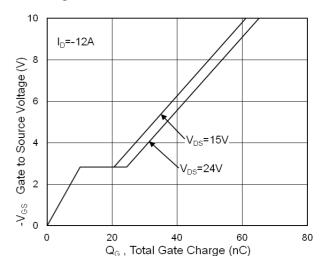


Fig.4 Gate-Charge Characteristics

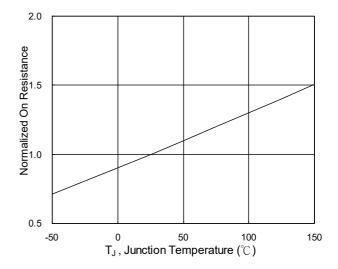
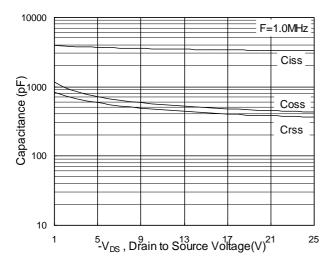


Fig.6 Normalized R_{DSON} vs. T_J



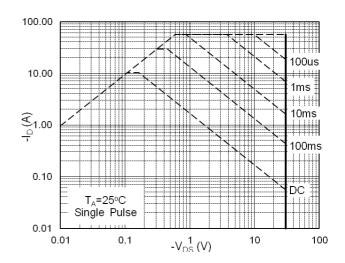


Fig.7 Capacitance

Fig.8 Safe Operating Area

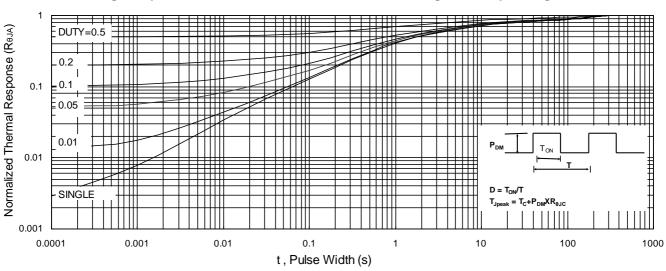


Fig.9 Normalized Maximum Transient Thermal Impedance

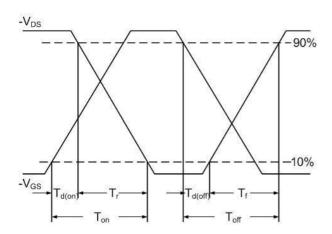


Fig.10 Switching Time Waveform

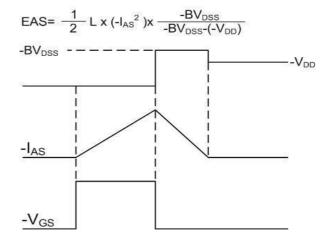
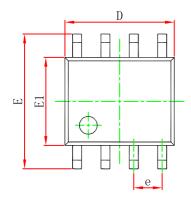
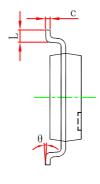


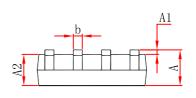
Fig.11 Unclamped Inductive Switching Waveform



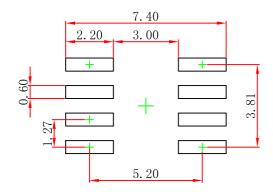
SOP-8(SO-8) Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
A	1.350	1.750	0.053	0.069	
A1	0.100	0. 250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
c	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0. 197	
e	1. 270 (BSC)	0.050 (BSC)		
E	5.800	6. 200	0. 228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



- Note:
 1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

P-Channel Enhancement Mode MOSFET

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